

TLE2027, TLE2037, TLE2027A, TLE2037A, TLE2027Y, TLE2037Y EXCALIBUR LOW-NOISE HIGH-SPEED PRECISION OPERATIONAL AMPLIFIERS

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- **Outstanding Combination of dc Precision and AC Performance:**

Unity-Gain Bandwidth . . . 15 MHz Typ

V_n 3.3 nV/ $\sqrt{\text{Hz}}$ at $f = 10$ Hz Typ,
2.5 nV/ $\sqrt{\text{Hz}}$ at $f = 1$ kHz Typ

V_{IO} 25 μV Max

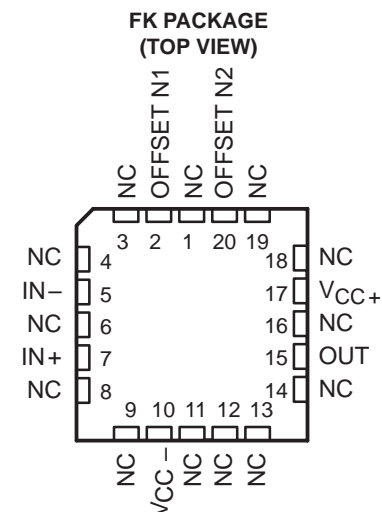
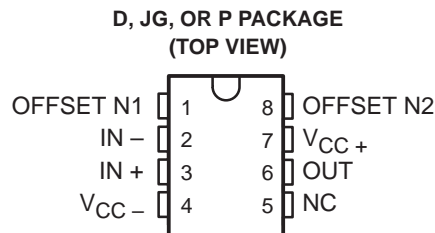
A_{VD} . . . 45 V/ μV Typ With $R_L = 2$ k Ω ,
19 V/ μV Typ With $R_L = 600$ Ω

- Available in Standard-Pinout Small-Outline Package
- Output Features Saturation Recovery Circuitry
- Macromodels and Statistical information

description

The TLE20x7 and TLE20x7A contain innovative circuit design expertise and high-quality process control techniques to produce a level of ac performance and dc precision previously unavailable in single operational amplifiers. Manufactured using Texas Instruments state-of-the-art Excalibur process, these devices allow upgrades to systems that use lower-precision devices.

In the area of dc precision, the TLE20x7 and TLE20x7A offer maximum offset voltages of 100 μV and 25 μV , respectively, common-mode rejection ratio of 131 dB (typ), supply voltage rejection ratio of 144 dB (typ), and dc gain of 45 V/ μV (typ).



AVAILABLE OPTIONS

T_A	$V_{IO\text{max}}$ AT 25°C	PACKAGED DEVICES				CHIP FORM [‡] (Y)
		SMALL OUTLINE [†] (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	
0°C to 70°C	25 μV	TLE2027ACD TLE2037ACD	—	—	TLE2027ACP TLE2037ACP	TLE2027Y TLE2037Y
	100 μV	TLE2027CD TLE2037CD	—	—	TLE2027CP TLE2037CP	TLE2027Y TLE2037Y
-40°C to 105°C	25 μV	TLE2027AID TLE2037AID	—	—	TLE2027AIP TLE2037AIP	—
	100 μV	TLE2027ID TLE2037ID	—	—	TLE2027IP TLE2037IP	—
-55°C to 125°C	25 μV	TLE2027AMD TLE2037AMD	TLE2027AMFK TLE2037AMFK	TLE2027AMJG TLE2037AMJG	TLE2027AMP TLE2037AMP	—
	100 μV	TLE2027MD TLE2037MD	TLE2027MFK TLE2037MFK	TLE2027MJG TLE2037MJG	TLE2027MP TLE2037MP	—

[†] The D packages are available taped and reeled. Add R suffix to device type (e.g., TLE2027ACDR).

[‡] Chip forms are tested at 25°C only.



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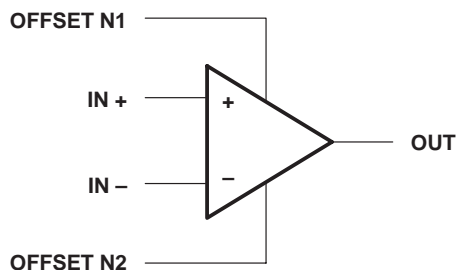
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description (continued)

The ac performance of the TLE2027 and TLE2037 is highlighted by a typical unity-gain bandwidth specification of 15 MHz, 55° of phase margin, and noise voltage specifications of 3.3 nV/ $\sqrt{\text{Hz}}$ and 2.5 nV/ $\sqrt{\text{Hz}}$ at frequencies of 10 Hz and 1 kHz respectively. The TLE2037 and TLE2037A have been decompensated for faster slew rate ($-7.5 \text{ V}/\mu\text{s}$, typical) and wider bandwidth (50 MHz). To ensure stability, the TLE2037 and TLE2037A should be operated with a closed-loop gain of 5 or greater.

Both the TLE20x7 and TLE20x7A are available in a wide variety of packages, including the industry-standard 8-pin small-outline version for high-density system applications. The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 105°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.

symbol

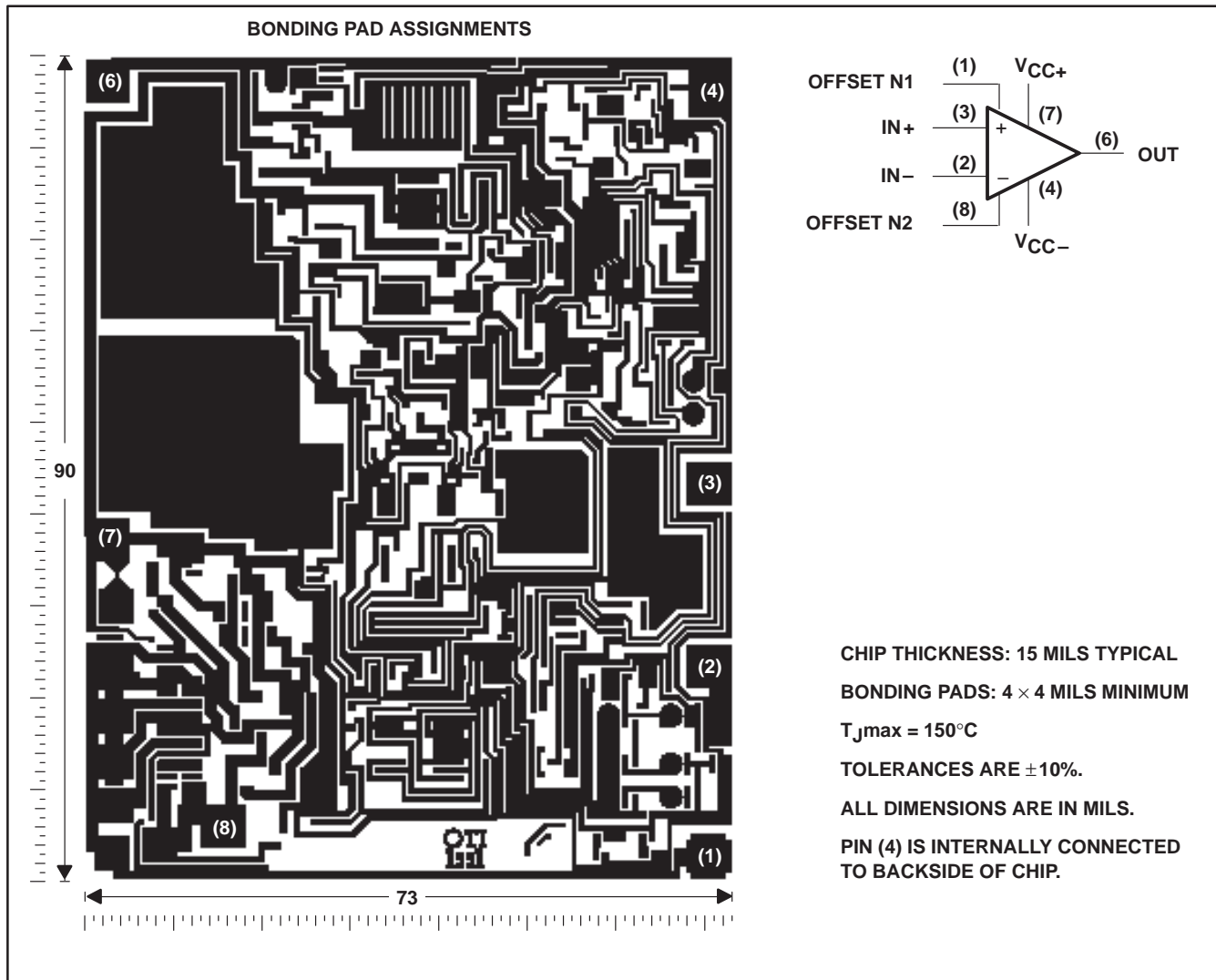


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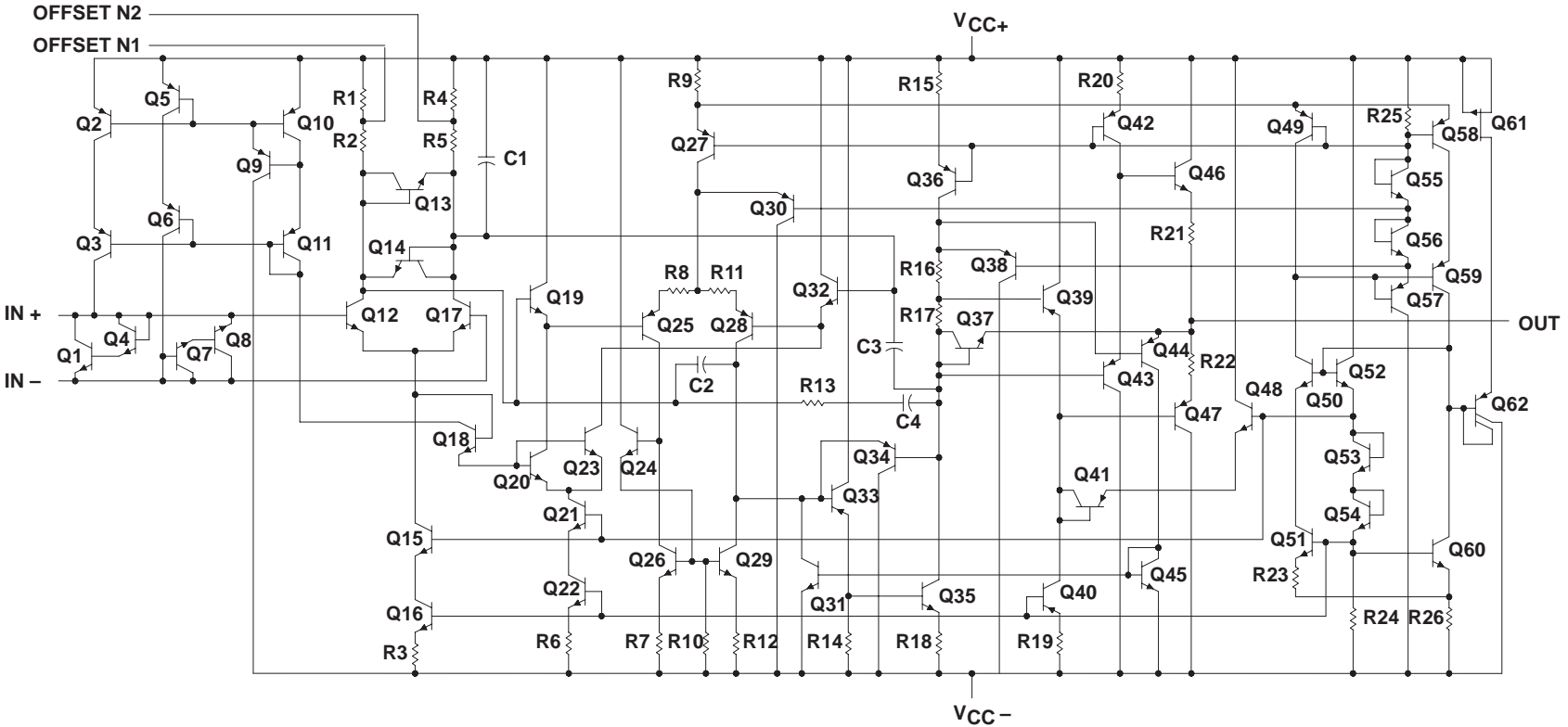
TLE202xY chip information

This chip, when properly assembled, displays characteristics similar to the TLE202xC. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



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equivalent schematic



ACTUAL DEVICE COMPONENT COUNT		
COMPONENT	TLE2027	TLE2037
Transistors	61	61
Resistors	26	26
epiFET	1	1
Capacitors	4	4

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC+} (see Note 1)	19 V
Supply voltage, V_{CC-}	– 19 V
Differential input voltage, V_{ID} (see Note 2)	± 1.2 V
Input voltage range, V_I (any input)	$V_{CC\pm}$
Input current, I_I (each Input)	± 1 mA
Output current, I_O	± 50 mA
Total current into V_{CC+}	50 mA
Total current out of V_{CC-}	50 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A : C suffix	0°C to 70°C
I suffix	– 40°C to 105°C
M suffix	– 55°C to 125°C
Storage temperature range, T_{stg}	– 65°C to 150°C
Case temperature for 60 seconds, T_C : FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or P package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package	300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-} .
 2. Differential voltages are at $IN+$ with respect to $IN-$. Excessive current flows if a differential input voltage in excess of approximately ± 1.2 V is applied between the inputs unless some limiting resistance is used.
 3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$	$T_A = 105^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING		POWER RATING	POWER RATING	POWER RATING
D	725 mW	5.8 mW/°C	464 mW	261 mW	145 mW
FK	1375 mW	11.0 mW/°C	880 mW	495 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	378 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	360 mW	200 mW

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUFFIX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, $V_{CC\pm}$		± 4	± 19	± 4	± 19	± 4	± 19	V
Common-mode input voltage, V_{IC}	$T_A = 25^\circ\text{C}$	–11	11	–11	11	–11	11	V
	$T_A = \text{Full range}^\ddagger$	–10.5	10.5	–10.4	10.4	–10.2	10.2	
Operating free-air temperature, T_A		0	70	–40	105	–55	125	°C

‡ Full range is 0°C to 70°C for C-suffix devices, –40°C to 105°C for I-suffix devices, and –55°C to 125°C for M-suffix devices.



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TLE20x7C electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE20x7C			TLE20x7AC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	20	100		10	25	μV	
		Full range			145		70		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4	1		0.2	1	$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.006	1		0.006	1	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	6	90		6	90	nA	
		Full range			150		150		
I_{IB} Input bias current	25°C	15	90		15	90	nA		
	Full range			150		150			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	25°C	-11 to 11	-13 to 13		-11 to 11	-13 to 13	V	
		Full range	-10.5 to 10.5			-10.5 to 10.5			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600\ \Omega$	25°C	10.5	12.9		10.5	12.9	V	
		Full range	10			10			
	$R_L = 2\ \text{k}\Omega$	25°C	12	13.2		12	13.2		
		Full range	11			11			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600\ \Omega$	25°C	-10.5	-13		-10.5	-13	V	
		Full range	-10			-10			
	$R_L = 2\ \text{k}\Omega$	25°C	-12	-13.5		-12	-13.5		
		Full range	-11			-11			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11\ \text{V}, R_L = 2\ \text{k}\Omega$	25°C	5	45		10	45	V/ μV	
	$V_O = \pm 10\ \text{V}, R_L = 2\ \text{k}\Omega$	Full range	2			4			
	$V_O = \pm 10\ \text{V}, R_L = 1\ \text{k}\Omega$	25°C	3.5	38		8	38		
		Full range	1			2.5			
	$V_O = \pm 10\ \text{V}, R_L = 600\ \Omega$	25°C	2	19		5	19		
		Full range	0.5			2			
C_i Input capacitance		25°C	8		8		pF		
z_o Open-loop output impedance	$I_O = 0$	25°C	50		50		Ω		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50\ \Omega$	25°C	100	131		117	131	dB	
		Full range	98			114			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	25°C	94	144		110	144	dB	
	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	Full range	92			106			
I_{CC} Supply current	$V_O = 0, \text{ No load}$	25°C	3.8	5.3		3.8	5.3	mA	
		Full range			5.6		5.6		

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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TLE20x7C operating characteristics at specified free-air temperature, $V_{CC \pm} = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise specified)

PARAMETER	TEST CONDITIONS		TLE20x7C			TLE20x7AC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	TLE2027	1.7	2.8		1.7	2.8	V/ μs	
		TLE2037	6	7.5		6	7.5		
	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, $T_A = 0^\circ\text{C}$ to 70°C , See Figure 1	TLE2027	1.2			1.2			
		TLE2037	5			5			
V_n Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $R_S = 20\ \Omega$,	$f = 10\text{ Hz}$		3.3	8		3.3	4.5	nV/ $\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$		2.5	4.5		2.5	3.8	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz}$ to 10 Hz			50	250		50	130	nV
I_n Equivalent input noise current	$f = 10\text{ Hz}$			1.5	4		1.5	4	pA/ $\sqrt{\text{Hz}}$
	$f = 1\text{ kHz}$			0.4	0.6		0.4	0.6	
THD Total harmonic distortion	$V_O = +10\text{ V}$, $A_{VD} = 1$, See Note 5	TLE2027	<0.002%			<0.002%			
		TLE2037	<0.002%			<0.002%			
B_1 Unity-gain bandwidth (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	7	13		9	13	MHz	
		TLE2037	35	50		35	50		
B_{OM} Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	TLE2027	30			30			kHz
		TLE2037	80			80			
ϕ_m Phase margin at unity gain (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	55°			55°			
		TLE2037	50°			50°			

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

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TLE20x7I electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE20x7I			TLE20x7AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	20	100		10	25	μV	
		Full range			180		105		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4	1		0.2	1	$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.006	1		0.006	1	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	6	90		6	90	nA	
		Full range			150		150		
I_{IB} Input bias current	25°C	15	90		15	90	nA		
	Full range			150		150			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	25°C	-11 to 11	-13 to 13		-11 to 11	-13 to 13	V	
		Full range	-10.4 to 10.4			-10.4 to 10.4			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600\ \Omega$	25°C	10.5	12.9		10.5	12.9	V	
		Full range	10			10			
	$R_L = 2\ \text{k}\Omega$	25°C	12	13.2		12	13.2		
		Full range	11			11			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600\ \Omega$	25°C	-10.5	-13		-10.5	-13	V	
		Full range	-10			-10			
	$R_L = 2\ \text{k}\Omega$	25°C	-12	-13.5		-12	-13.5		
		Full range	-11			-11			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11\ \text{V}, R_L = 2\ \text{k}\Omega$	25°C	5	45		10	45	$\text{V}/\mu\text{V}$	
	$V_O = \pm 10\ \text{V}, R_L = 2\ \text{k}\Omega$	Full range	2			3.5			
	$V_O = \pm 10\ \text{V}, R_L = 1\ \text{k}\Omega$	25°C	3.5	38		8	38		
		Full range	1			2.2			
	$V_O = \pm 10\ \text{V}, R_L = 600\ \Omega$	25°C	2	19		5	19		
		Full range	0.5			1.1			
C_i Input capacitance		25°C	8		8		pF		
z_o Open-loop output impedance	$I_O = 0$	25°C	50		50		Ω		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50\ \Omega$	25°C	100	131		117	131	dB	
		Full range	96			113			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	25°C	94	144		110	144	dB	
	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	Full range	90			105			
I_{CC} Supply current	$V_O = 0, \text{ No load}$	25°C	3.8	5.3		3.8	5.3	mA	
		Full range			5.6		5.6		

† Full range is -40°C to 105°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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TLE20x7I operating characteristics at specified free-air temperature, $V_{CC \pm} = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise specified)

PARAMETER	TEST CONDITIONS		TLE20x7I			TLE20x7AI			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR	Slew rate at unity gain	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	TLE2027	1.7	2.8		1.7	2.8	V/ μs	
			TLE2037	6	7.5		6	7.5		
	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, $T_A = -40^\circ\text{C}$ to 85°C , See Figure 1	TLE2027	1.1			1.1				
		TLE2037	4.7			4.7				
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\text{ Hz}$		3.3	8		3.3	4.5	nV/ $\sqrt{\text{Hz}}$	
			$R_S = 20\ \Omega$, $f = 1\text{ kHz}$		2.5	4.5		2.5		3.8
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz}$ to 10 Hz			50	250		50	130	nV
I_n	Equivalent input noise current	$f = 10\text{ Hz}$			1.5	4		1.5	4	pA/ $\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$			0.4	0.6		0.4	0.6	
THD	Total harmonic distortion	$V_O = +10\text{ V}$, $A_{VD} = 1$, See Note 5	TLE2027	< 0.002%			< 0.002%			
		$V_O = +10\text{ V}$, $A_{VD} = 5$, See Note 5	TLE2037	< 0.002%			< 0.002%			
B_1	Unity-gain bandwidth (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	7	13		9	13	MHz	
			TLE2037	35	50		35	50		
B_{OM}	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	TLE2027	30			30		kHz	
			TLE2037	80			80			
ϕ_m	Phase margin at unity gain (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	55°			55°			
			TLE2037	50°			50°			

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

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TLE20x7M electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE20x7M			TLE20x7AM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\ \Omega$	25°C	20	100		10	25	μV	
		Full range			200		105		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4	1*		0.2	1*	$\mu\text{V}/^\circ\text{C}$	
Input offset voltage long-term drift (see Note 4)		25°C	0.006	1*		0.006	1*	$\mu\text{V}/\text{mo}$	
I_{IO} Input offset current		25°C	6	90		6	90	nA	
		Full range			150		150		
I_{IB} Input bias current	25°C	15	90		15	90	nA		
	Full range			150		150			
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	25°C	-11 to 11	-13 to 13		-11 to 11	-13 to 13	V	
		Full range	-10.3 to 10.3			-10.4 to 10.4			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600\ \Omega$	25°C	10.5	12.9		10.5	12.9	V	
		Full range	10			10			
	$R_L = 2\ \text{k}\Omega$	25°C	12	13.2		12	13.2		
		Full range	11			11			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600\ \Omega$	25°C	-10.5	-13		-10.5	-13	V	
		Full range	-10			-10			
	$R_L = 2\ \text{k}\Omega$	25°C	-12	-13.5		-12	-13.5		
		Full range	-11			-11			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11\ \text{V}, R_L = 2\ \text{k}\Omega$	25°C	5	45		10	45	$\text{V}/\mu\text{V}$	
	$V_O = \pm 10\ \text{V}, R_L = 2\ \text{k}\Omega$	Full range	2.5			3.5			
	$V_O = \pm 10\ \text{V}, R_L = 1\ \text{k}\Omega$	25°C	3.5	38		8	38		
		Full range	1.8			2.2			
	$V_O = \pm 10\ \text{V}, R_L = 600\ \Omega$	25°C	2	19		5	19		
C_i Input capacitance		25°C		8		8	pF		
z_o Open-loop output impedance	$I_O = 0$	25°C		50		50	Ω		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50\ \Omega$	25°C	100	131		117	131	dB	
		Full range	96			113			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	25°C	94	144		110	144	dB	
	$V_{CC\pm} = \pm 4\ \text{V to } \pm 18\ \text{V}, R_S = 50\ \Omega$	Full range	90			105			
I_{CC} Supply current	$V_O = 0, \text{ No load}$	25°C	3.8	5.3		3.8	5.3	mA	
		Full range			5.6		5.6		

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

† Full range is -55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2027, TLE2037, TLE2027A, TLE2037A, TLE2027Y, TLE2037Y
EXCALIBUR LOW-NOISE HIGH-SPEED
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TLE20x7M operating characteristics at specified free-air temperature, $V_{CC} \pm = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise specified)

PARAMETER	TEST CONDITIONS		TLE20x7M			TLE20x7AM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	TLE2027	1.7	2.8		1.7	2.8	V/ μs
			TLE2037	6*	7.5		6*	7.5	
	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, $T_A = -55^\circ\text{C}$ to 125°C , See Figure 1	TLE2027	1			1			
		TLE2037	4.4*			4.4*			
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\text{ Hz}$		3.3	8*		3.3	4.5*	nV/ $\sqrt{\text{Hz}}$
			$R_S = 20\ \Omega$, $f = 1\text{ kHz}$		2.5	4.5*		2.5	
$V_N(\text{PP})$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz}$ to 10 Hz		50	250*		50	130*	nV
I_n	Equivalent input noise current	$f = 10\text{ Hz}$		1.5	4*		1.5	4*	pA/ $\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$		0.4	0.6*		0.4	0.6*	
THD	Total harmonic distortion	$V_O = +10\text{ V}$, $A_{VD} = 1$, See Note 5	TLE2027	< 0.002%			< 0.002%		
		$V_O = +10\text{ V}$, $A_{VD} = 5$, See Note 5	TLE2037	< 0.002%			< 0.002%		
B_1	Unity-gain bandwidth (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	7*	13		9*	13	MHz
			TLE2037	35	50		35	50	
B_{OM}	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	TLE2027	30			30		kHz
			TLE2037	80			80		
ϕ_m	Phase margin at unity gain (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	55°			55°		
			TLE2037	50°			50°		

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

TLE2027, TLE2037, TLE2027A, TLE2037A, TLE2027Y, TLE2037Y
EXCALIBUR LOW-NOISE HIGH-SPEED
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TLE20x7Y electrical characteristics, $V_{CC\pm} = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLE20x7Y			UNIT
		MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0$, $R_S = 50\ \Omega$	20			μV
Input offset voltage long-term drift (see Note 4)		0.006			$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		6			nA
I_{IB} Input bias current		15			nA
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	-13 to 13			V
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600\ \Omega$	12.9			V
	$R_L = 2\ \text{k}\Omega$	13.2			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600\ \Omega$	-13			V
	$R_L = 2\ \text{k}\Omega$	-13.5			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11\ \text{V}$, $R_L = 2\ \text{k}\Omega$	45			V/ μV
	$V_O = \pm 10\ \text{V}$, $R_L = 1\ \text{k}\Omega$	38			
	$V_O = \pm 10\ \text{V}$, $R_L = 600\ \Omega$	19			
C_i Input capacitance		8			pF
z_o Open-loop output impedance	$I_O = 0$	50			Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\ \Omega$	131			dB
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4\ \text{V}$ to $\pm 18\ \text{V}$, $R_S = 50\ \Omega$	144			dB
I_{CC} Supply current	$V_O = 0$, No load	3.8			mA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2027, TLE2037, TLE2027A, TLE2037A, TLE2027Y, TLE2037Y
EXCALIBUR LOW-NOISE HIGH-SPEED
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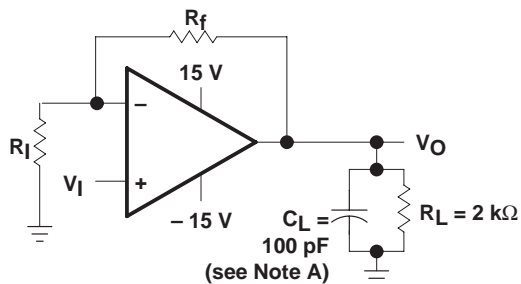
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TLE20x7Y operating characteristics at specified free-air temperature, $V_{CC \pm} = \pm 15\text{ V}$

PARAMETER		TEST CONDITIONS		TLE20x7Y			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	TLE2027	2.8		V/ μs	
			TLE2037	7.5			
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\text{ Hz}$ $R_S = 20\ \Omega$, $f = 1\text{ kHz}$	3.3		nV/ $\sqrt{\text{Hz}}$		
			2.5				
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz to }10\text{ Hz}$	50		nV		
I_n	Equivalent input noise current	$f = 10\text{ Hz}$	1.5		pA/ $\sqrt{\text{Hz}}$		
		$f = 1\text{ kHz}$	0.4				
THD	Total harmonic distortion	$V_O = +10\text{ V}$, $A_{VD} = 1$, See Note 5	TLE2027	<0.002%			
		$V_O = +10\text{ V}$, $A_{VD} = 5$, See Note 5	TLE2037	<0.002%			
B_1	Unity-gain bandwidth (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	13		MHz	
			TLE2037	50			
B_{OM}	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	TLE2027	30		kHz	
			TLE2037	80			
ϕ_m	Phase margin at unity gain (see Figure 3)	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	TLE2027	55°			
			TLE2037	50°			

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew-Rate Test Circuit

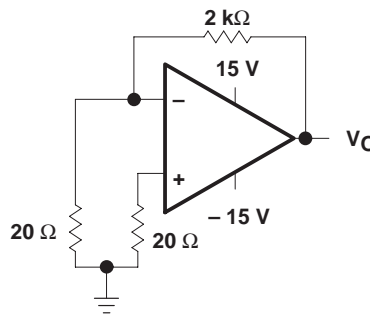
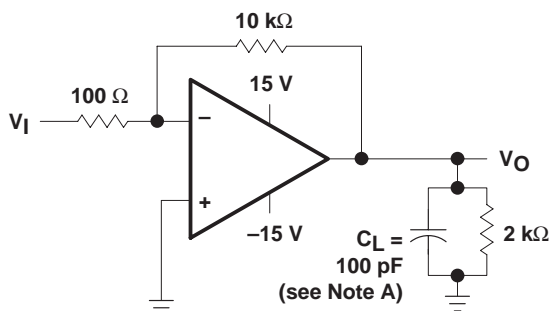
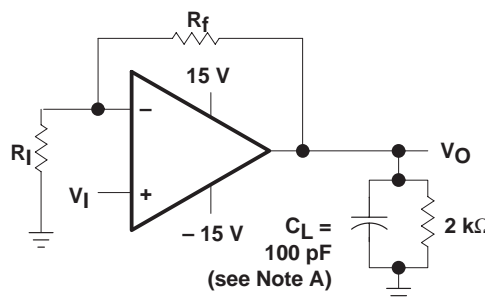


Figure 2. Noise-Voltage Test Circuit



NOTE A: C_L includes fixture capacitance.

Figure 3. Unity-Gain Bandwidth and Phase-Margin Test Circuit (TLE2027 Only)



NOTES: A. C_L includes fixture capacitance.
 B. For the TLE2037 and TLE2037A, A_{VD} must be ≥ 5 .

Figure 4. Small-Signal Pulse-Response Test Circuit

typical values

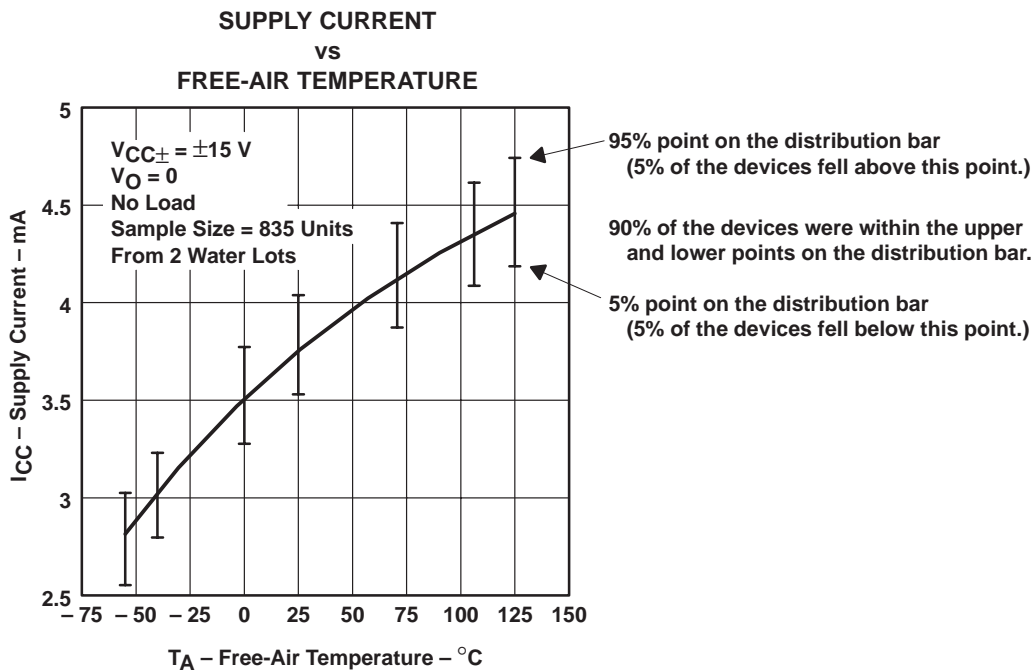
Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

initial estimates of parameter distributions

In the ongoing program of improving data sheets and supplying more information to our customers, Texas Instruments has added an estimate of not only the typical values but also the spread around these values. These are in the form of distribution bars that show the 95% (upper) points and the 5% (lower) points from the characterization of the initial wafer lots of this new device type (see Figure 5). The distribution bars are shown at the points where data was actually collected. The 95% and 5% points are used instead of ± 3 sigma since some of the distributions are not true Gaussian distributions.

The number of units tested and the number of different wafer lots used are on all of the graphs where distribution bars are shown. As noted in Figure 5, there were a total of 835 units from two wafer lots. In this case, there is a good estimate for the within-lot variability and a possibly poor estimate of the lot-to-lot variability. This is always the case on newly released products since there can only be data available from a few wafer lots.

The distribution bars are not intended to replace the minimum and maximum limits in the electrical tables. Each distribution bar represents 90% of the total units tested at a specific temperature. While 10% of the units tested fell outside any given distribution bar, this should not be interpreted to mean that the same individual devices fell outside every distribution bar.



TLE2027, TLE2037, TLE2027A, TLE2037A, TLE2027Y, TLE2037Y
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TYPICAL CHARACTERISTICS

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		vs Free-air temperature	18, 19
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ϕ_m	Phase margin	vs Supply voltage	50, 51
		vs Load capacitance	52, 53
		vs Free-air temperature	54, 55
	Phase shift	vs Frequency	22 – 25



TYPICAL CHARACTERISTICS

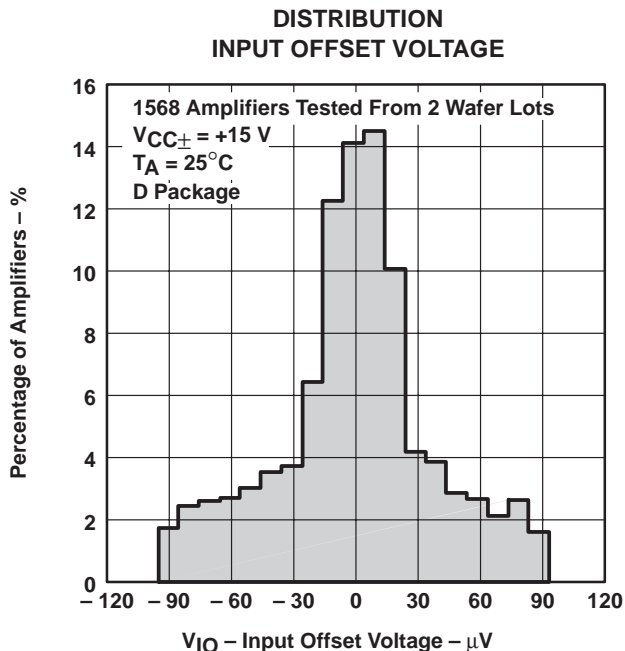


Figure 6

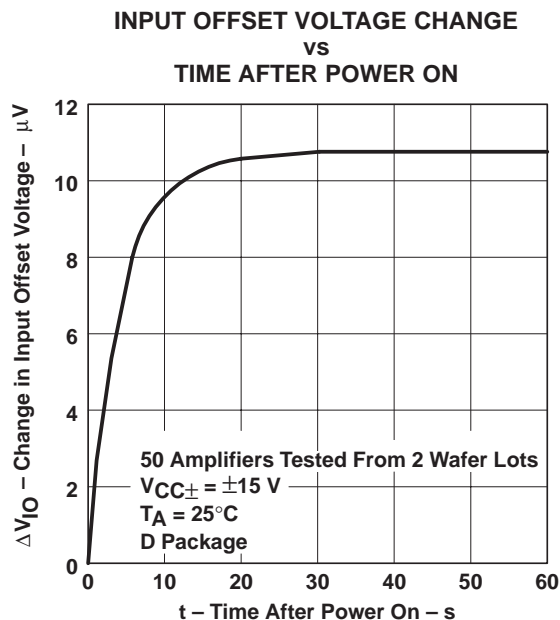


Figure 7

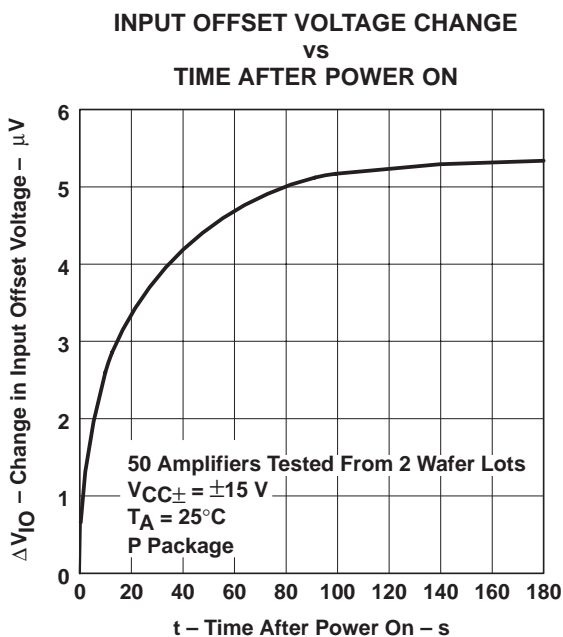


Figure 8

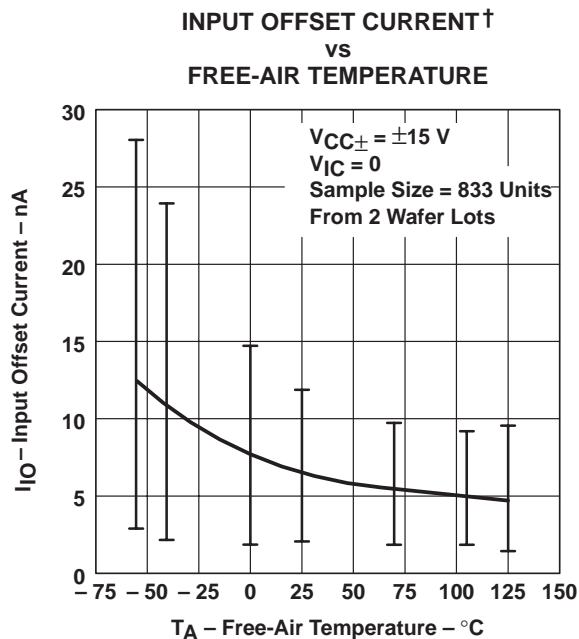


Figure 9

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

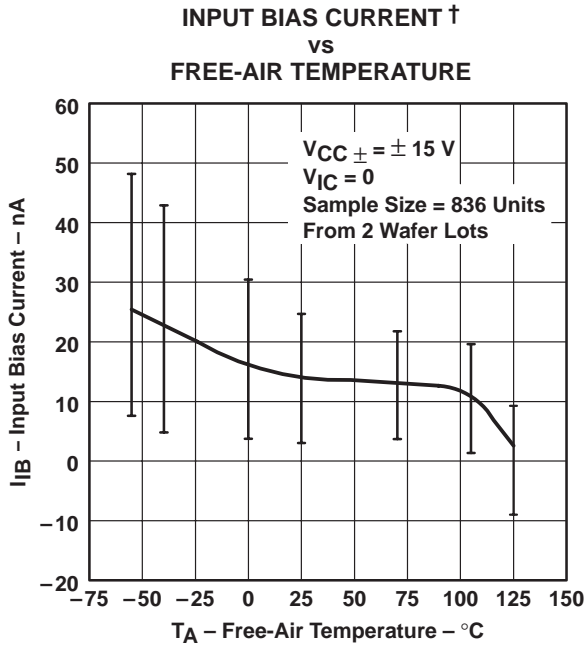


Figure 10

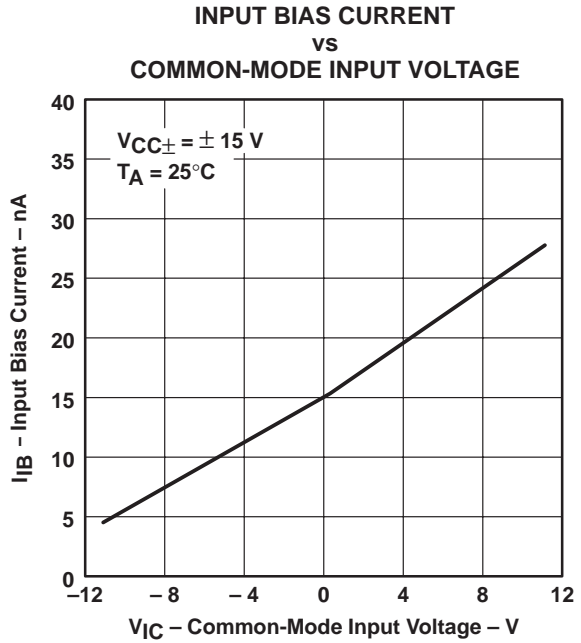


Figure 11

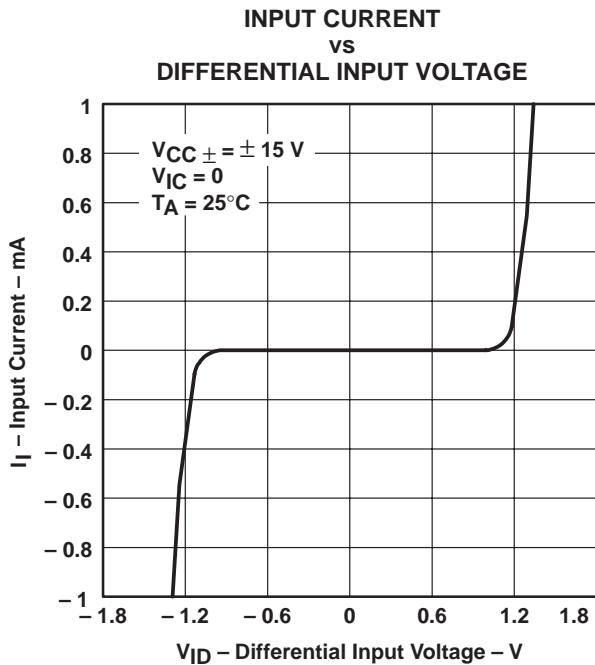


Figure 12

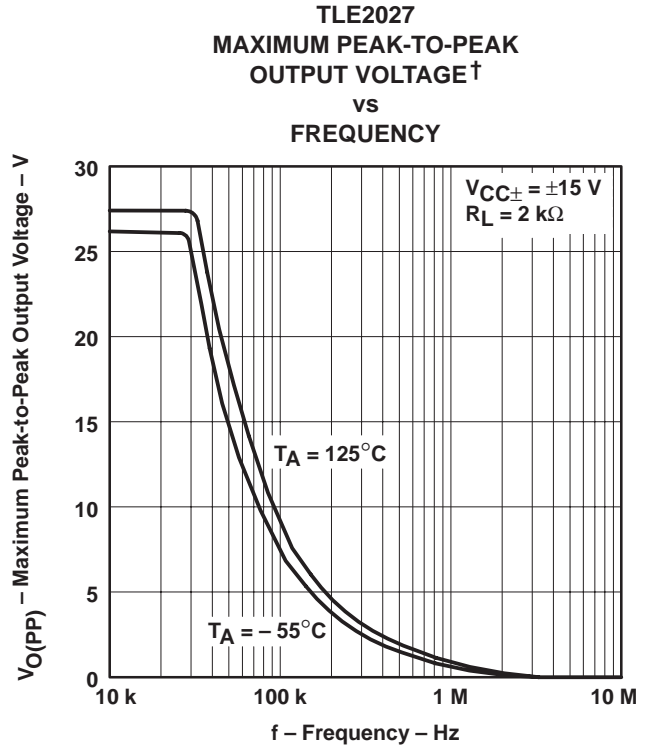


Figure 13

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2037
 MAXIMUM PEAK-TO-PEAK
 OUTPUT VOLTAGE†
 vs
 FREQUENCY

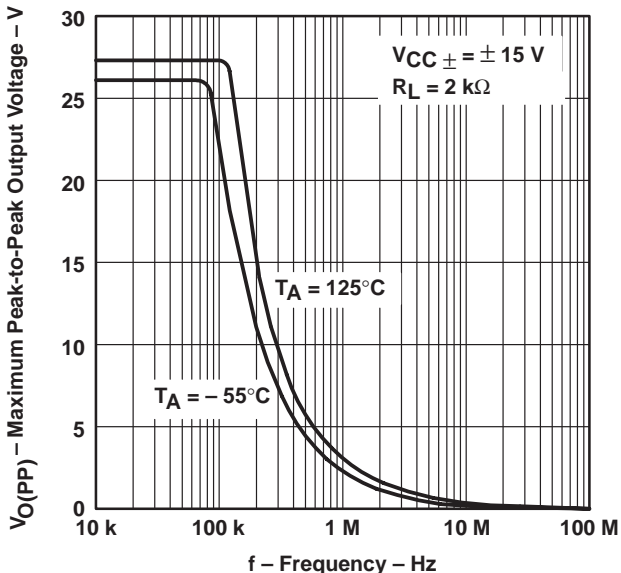


Figure 14

MAXIMUM POSITIVE PEAK
 OUTPUT VOLTAGE
 vs
 LOAD RESISTANCE

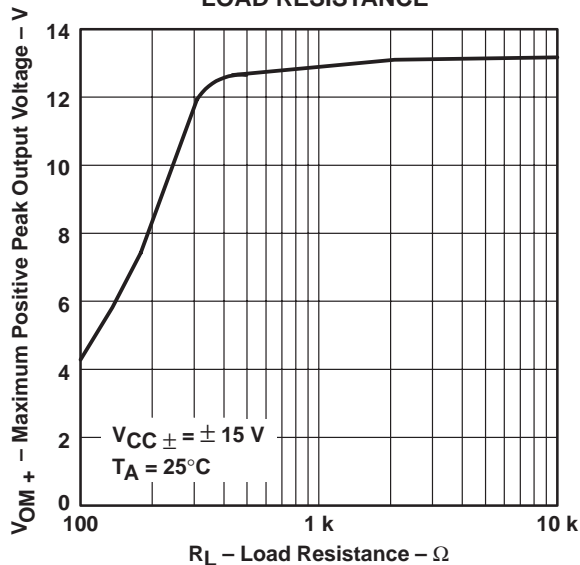


Figure 15

MAXIMUM NEGATIVE PEAK
 OUTPUT VOLTAGE
 vs
 LOAD RESISTANCE

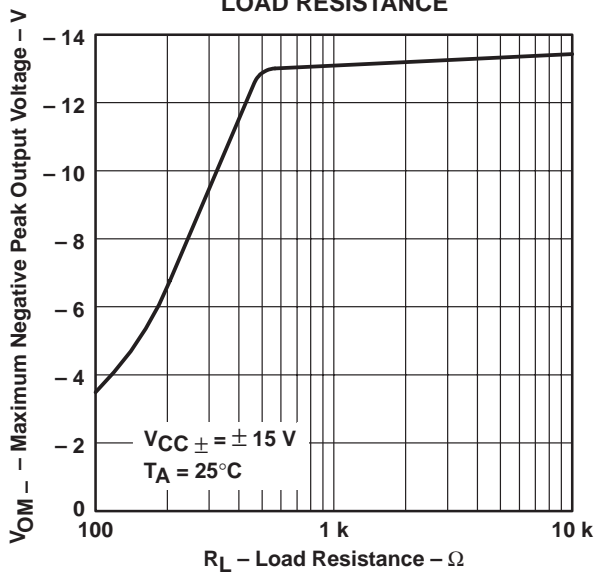


Figure 16

MAXIMUM POSITIVE PEAK
 OUTPUT VOLTAGE†
 vs
 FREE-AIR TEMPERATURE

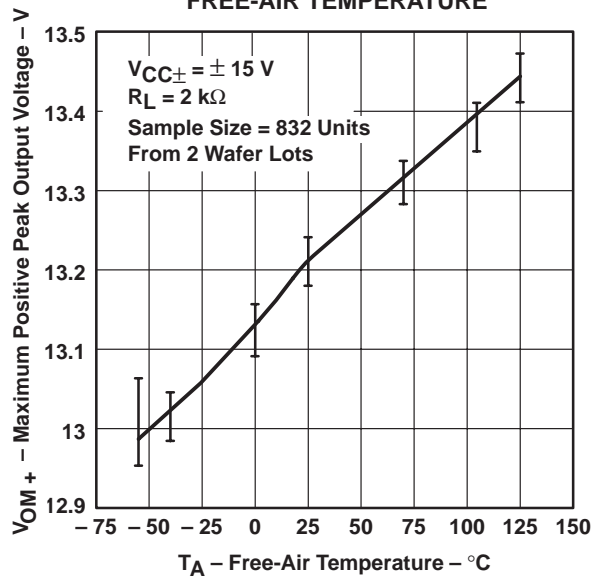
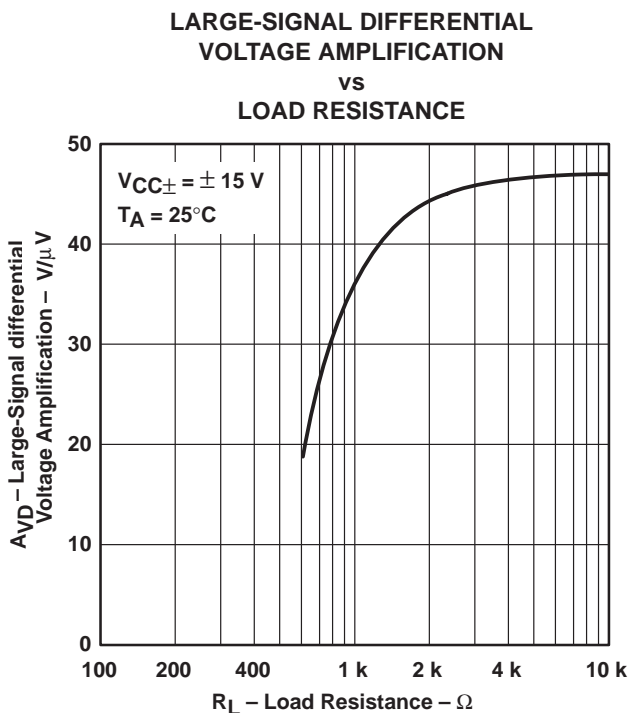
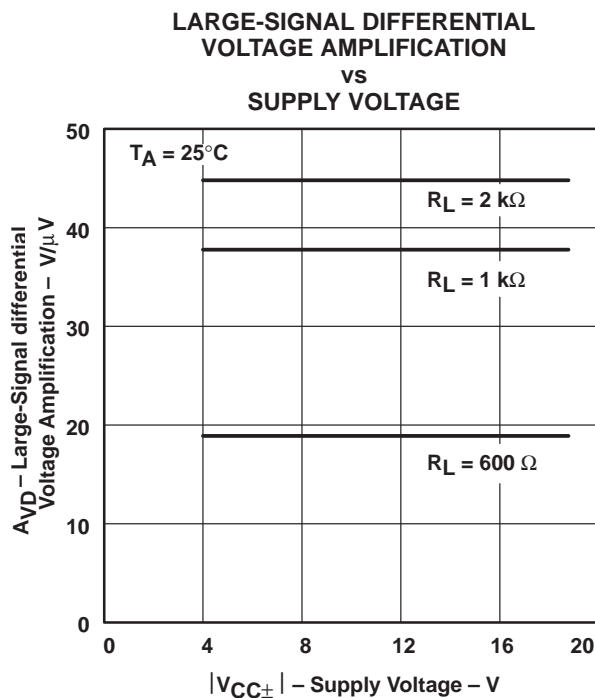
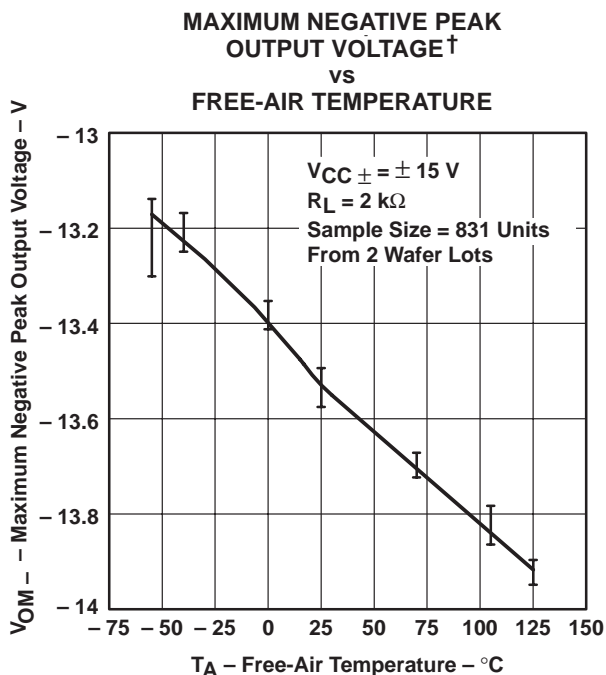


Figure 17

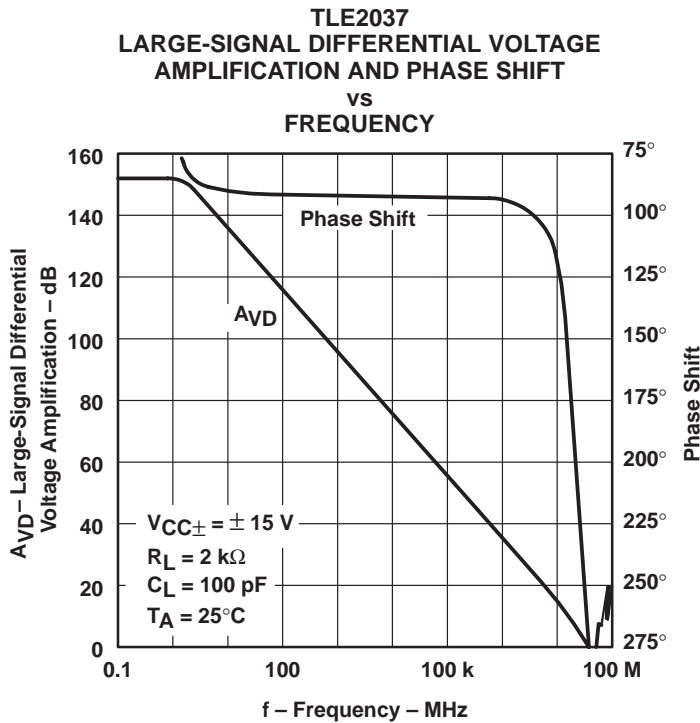
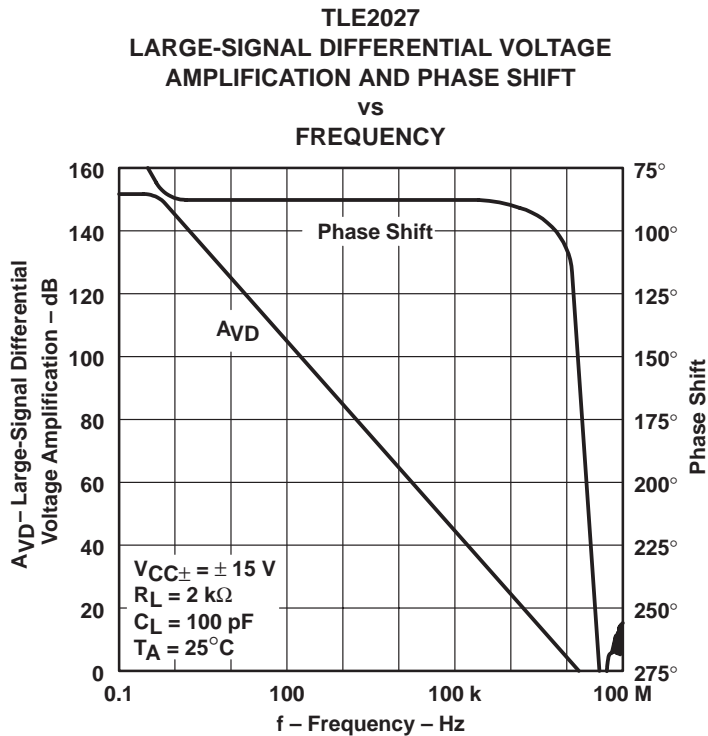
† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

TLE2027
 LARGE-SIGNAL DIFFERENTIAL VOLTAGE
 AMPLIFICATION AND PHASE SHIFT
 vs
 FREQUENCY

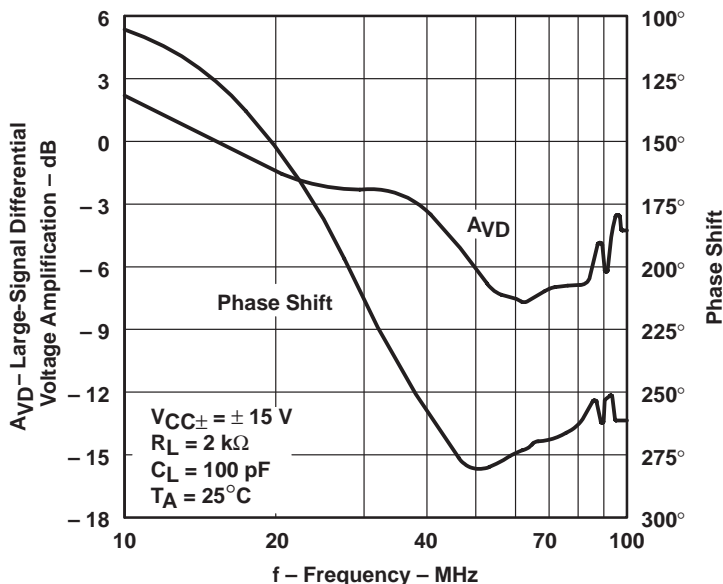


Figure 23

TLE2037
 LARGE-SIGNAL DIFFERENTIAL VOLTAGE
 AMPLIFICATION AND PHASE SHIFT
 vs
 FREQUENCY

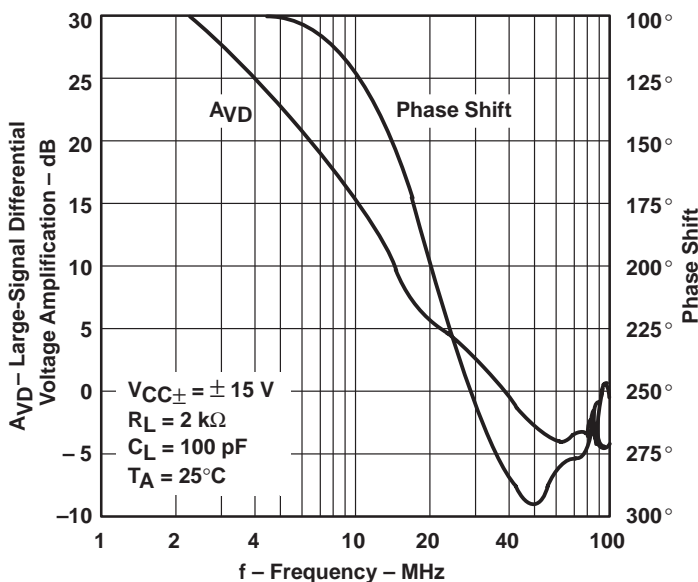


Figure 24

TYPICAL CHARACTERISTICS

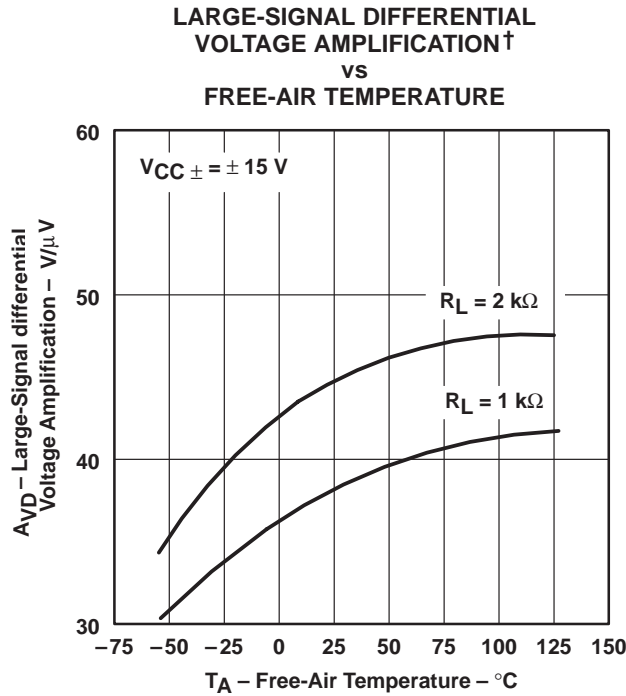
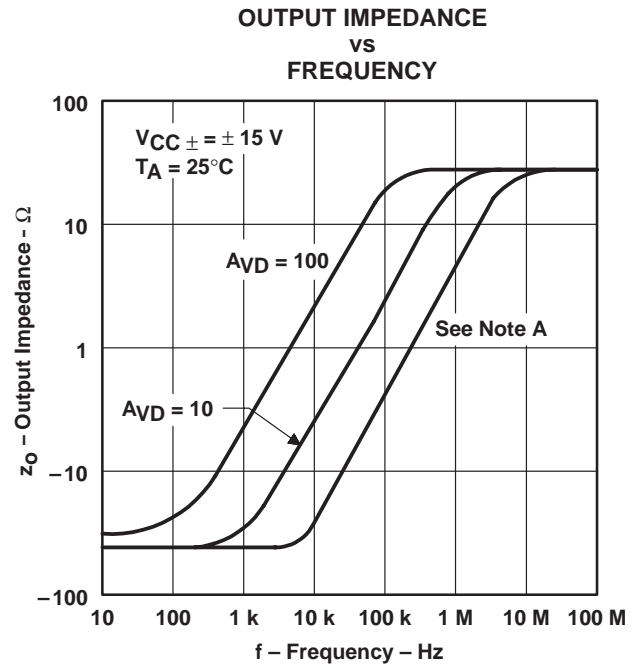


Figure 25



NOTE A: For this curve, the TLE2027 is $A_{VD} = 1$ and the TLE2037 is $A_{VD} = 5$.

Figure 26

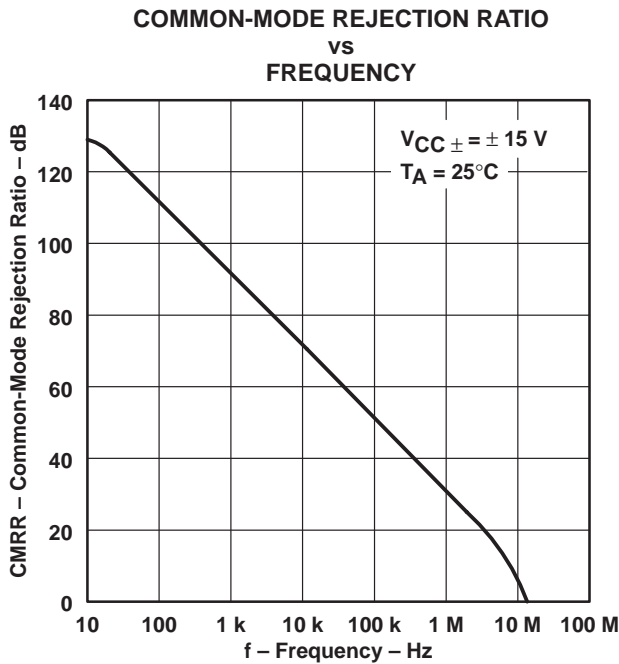


Figure 27

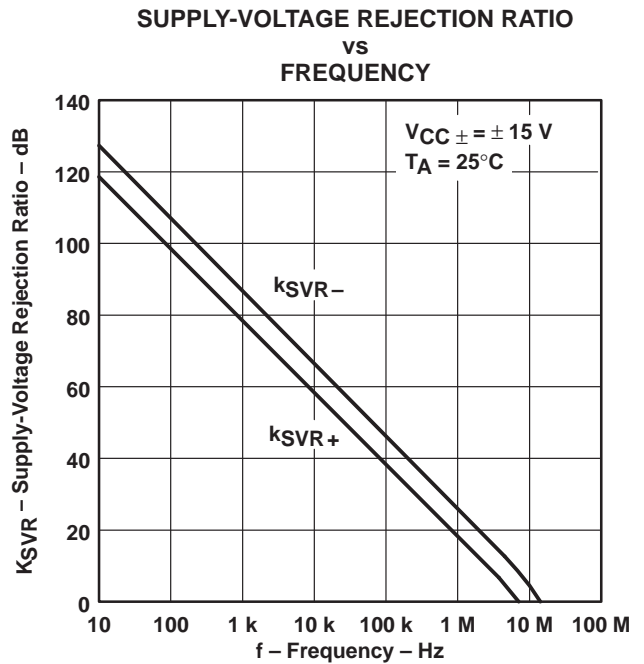


Figure 28

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 SUPPLY VOLTAGE

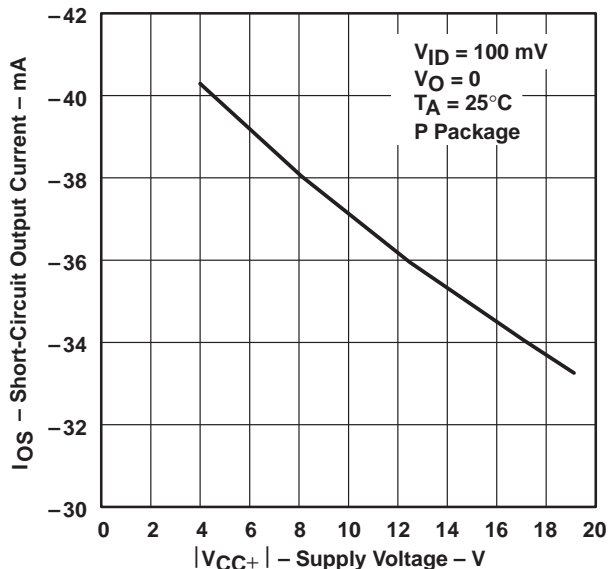


Figure 29

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 SUPPLY VOLTAGE

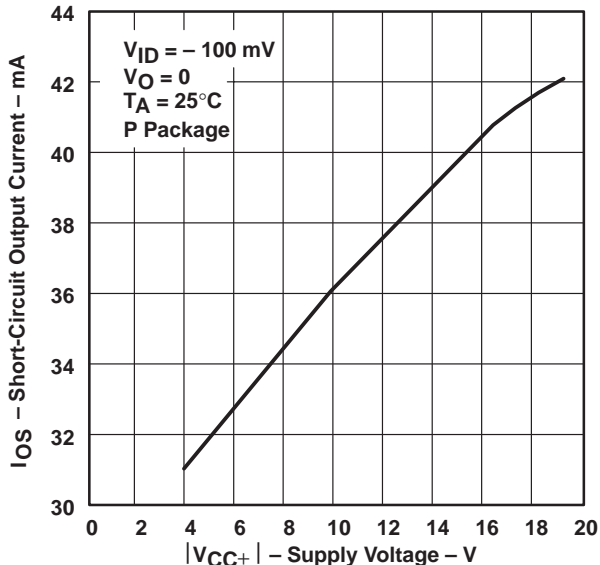


Figure 30

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 ELAPSED TIME

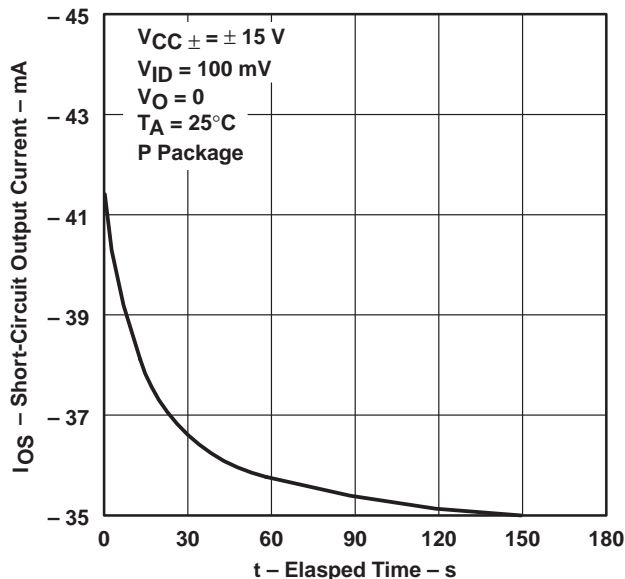


Figure 31

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 ELAPSED TIME

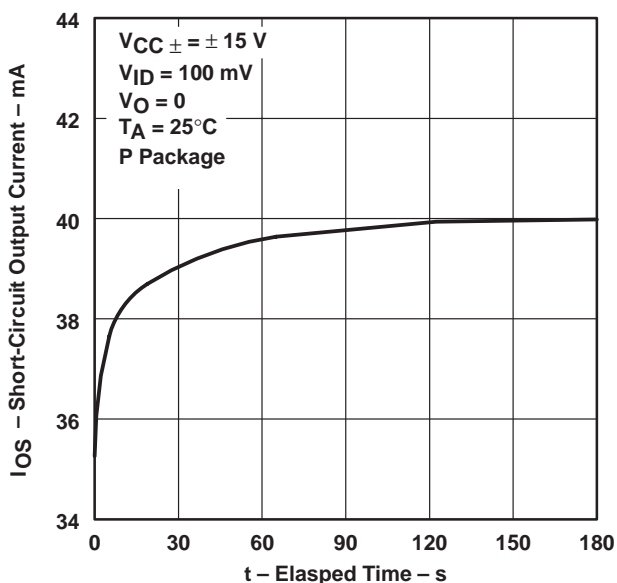


Figure 32

TYPICAL CHARACTERISTICS

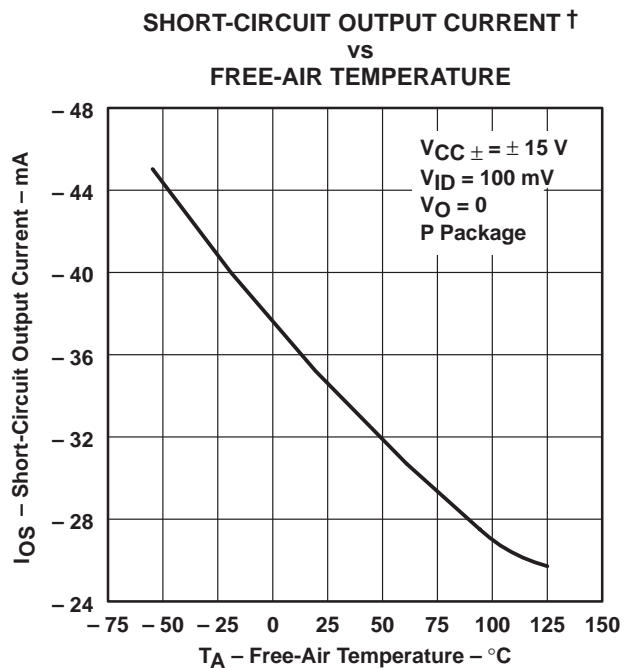


Figure 33

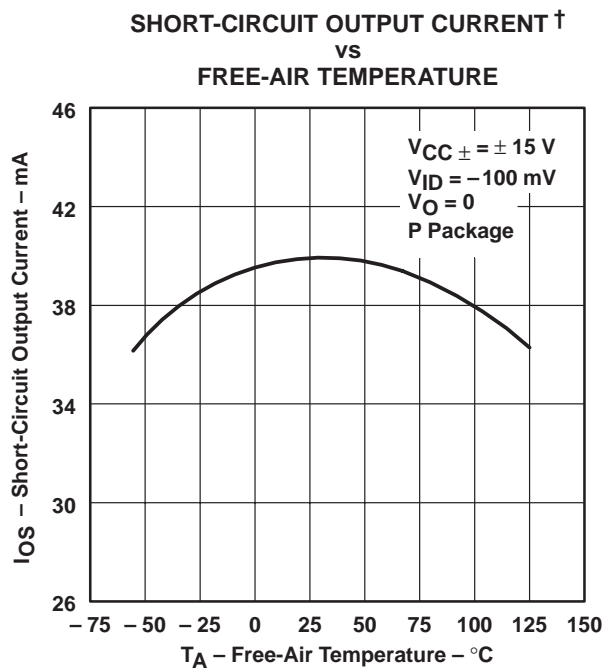


Figure 34

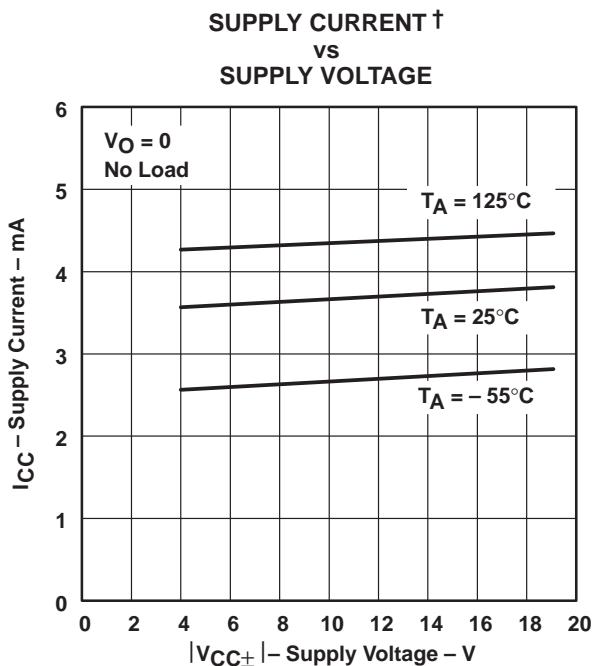


Figure 35

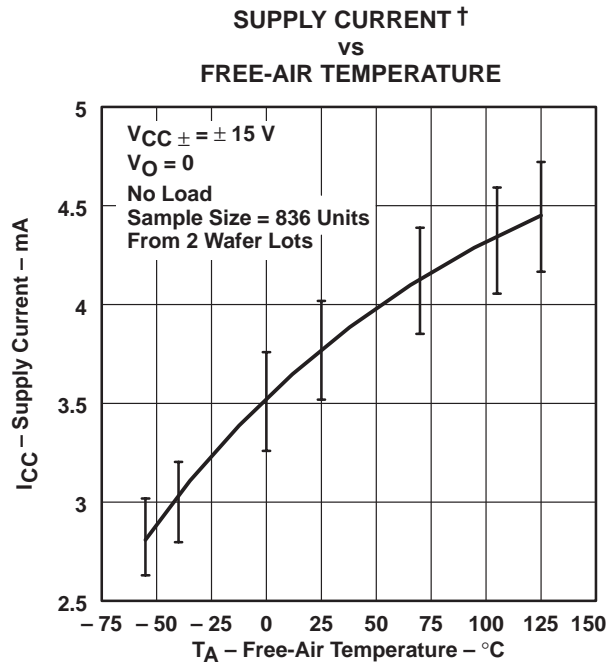


Figure 36

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2027
 VOLTAGE-FOLLOWER
 SMALL-SIGNAL
 PULSE RESPONSE

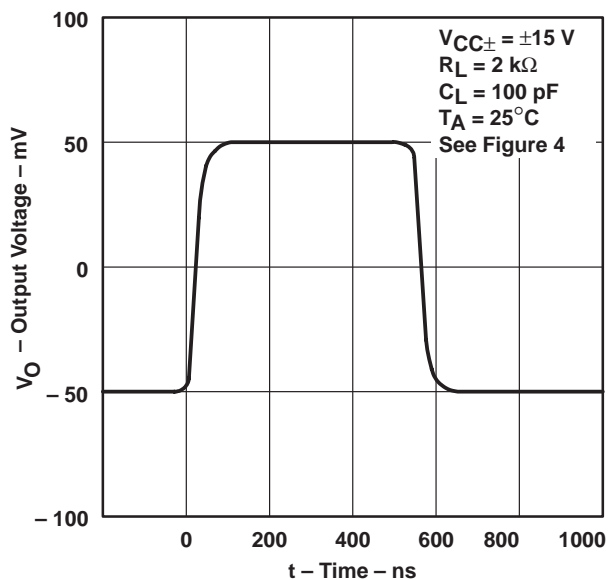


Figure 37

TLE2027
 VOLTAGE-FOLLOWER
 LARGE-SIGNAL
 PULSE RESPONSE

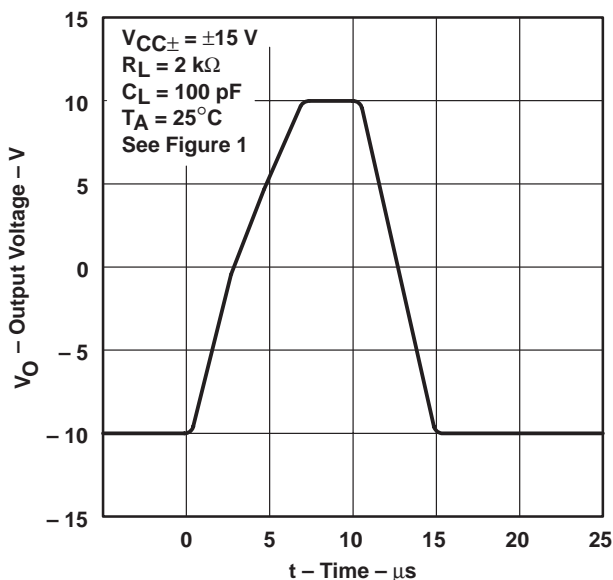


Figure 38

TLE2037
 VOLTAGE-FOLLOWER
 SMALL-SIGNAL
 PULSE RESPONSE

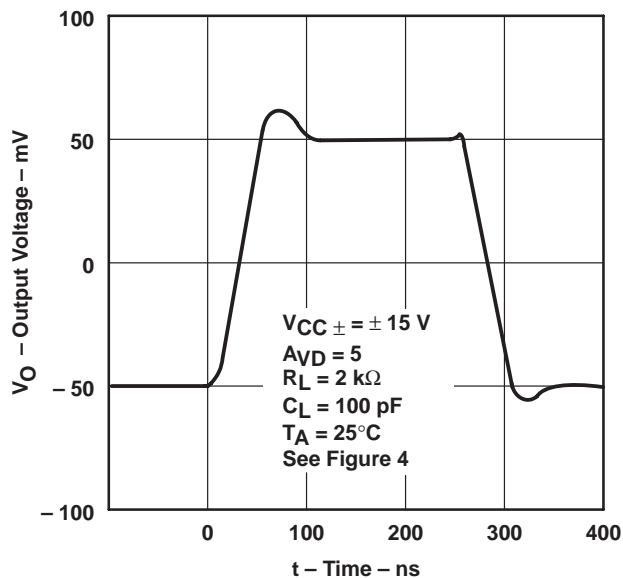


Figure 39

TLE2037
 VOLTAGE-FOLLOWER
 LARGE-SIGNAL
 PULSE RESPONSE

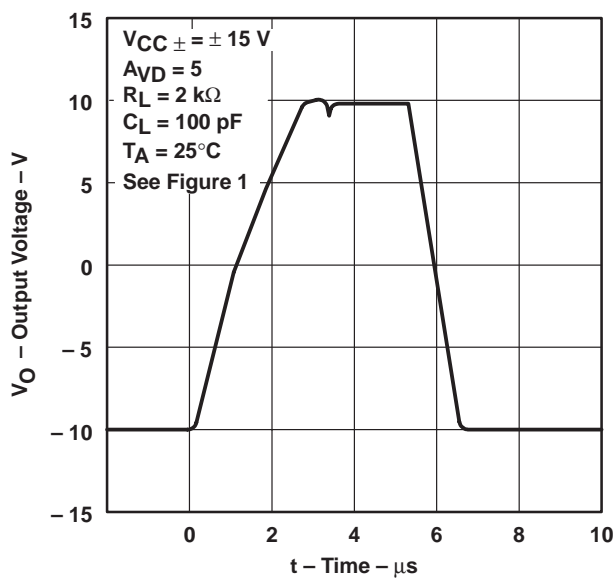
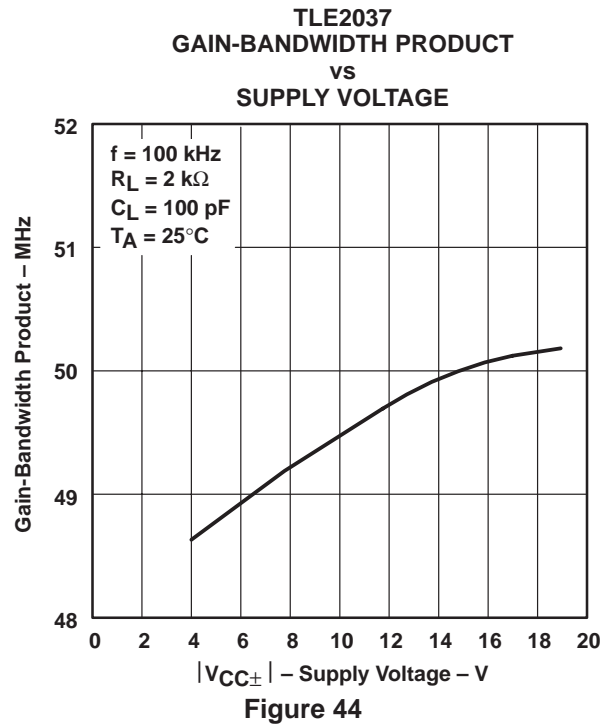
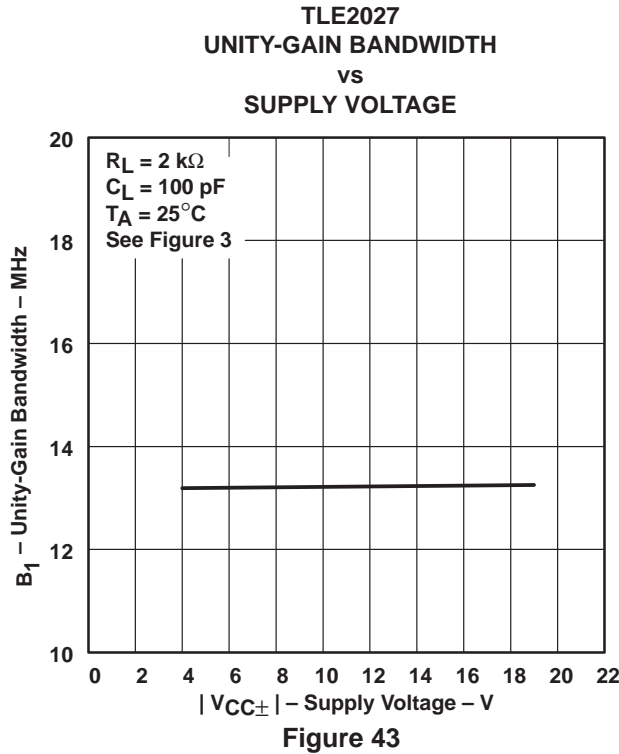
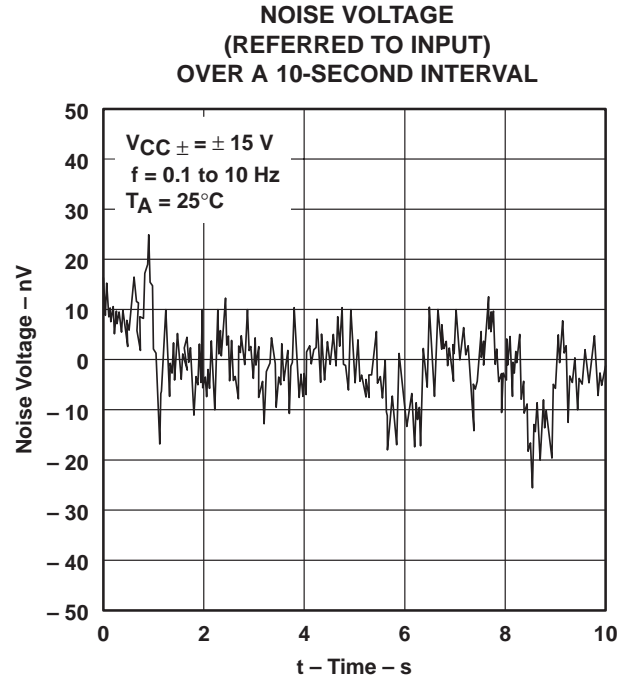
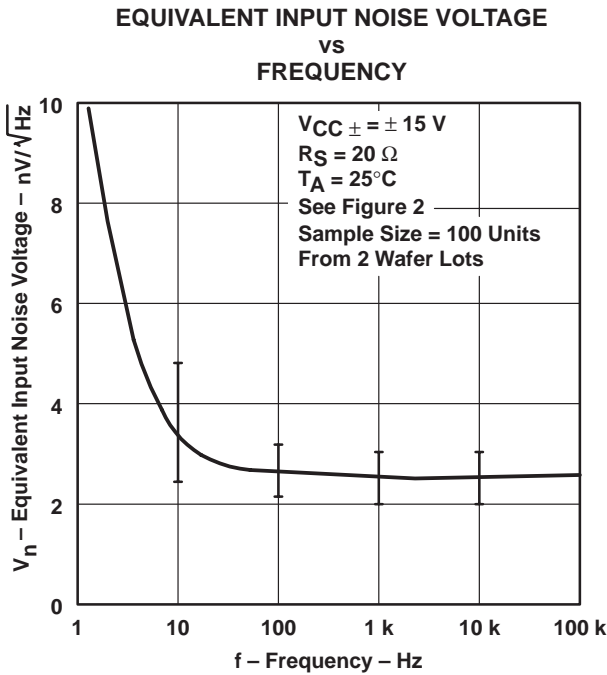


Figure 40

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

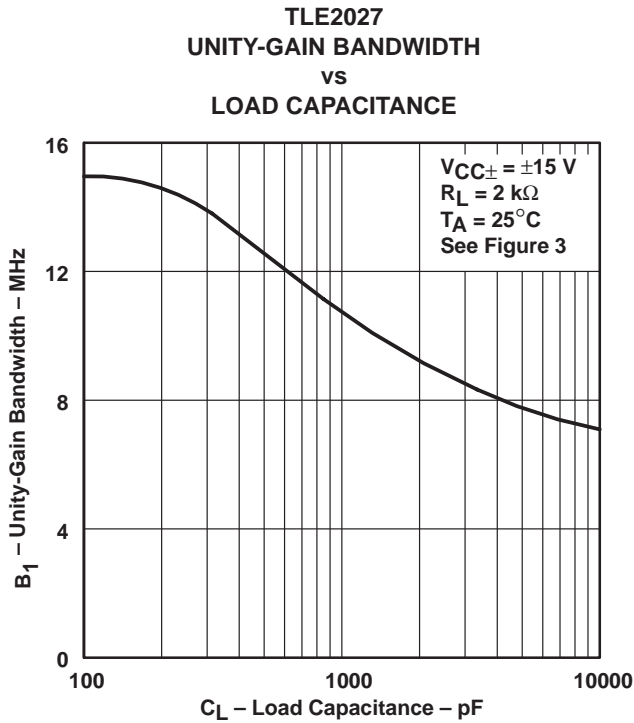


Figure 45

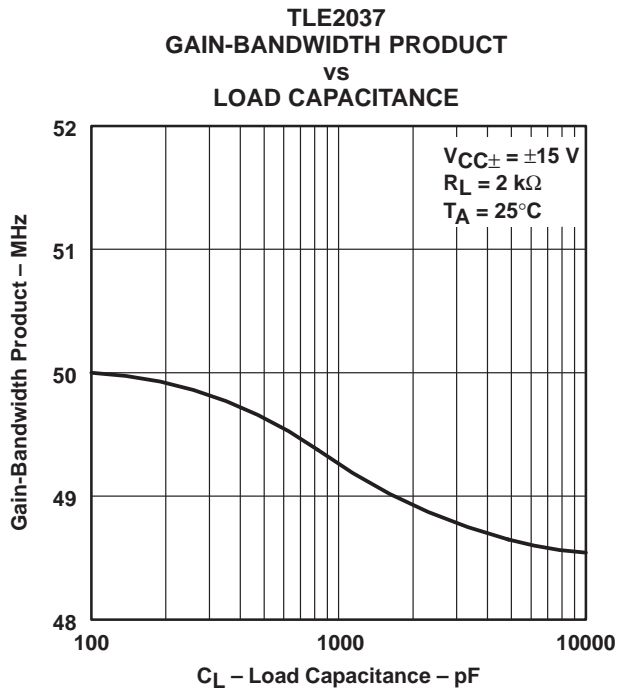


Figure 46

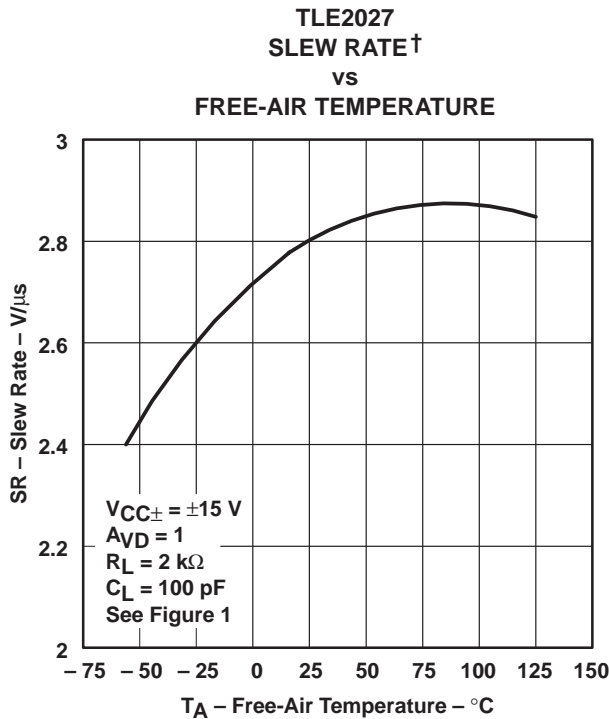


Figure 47

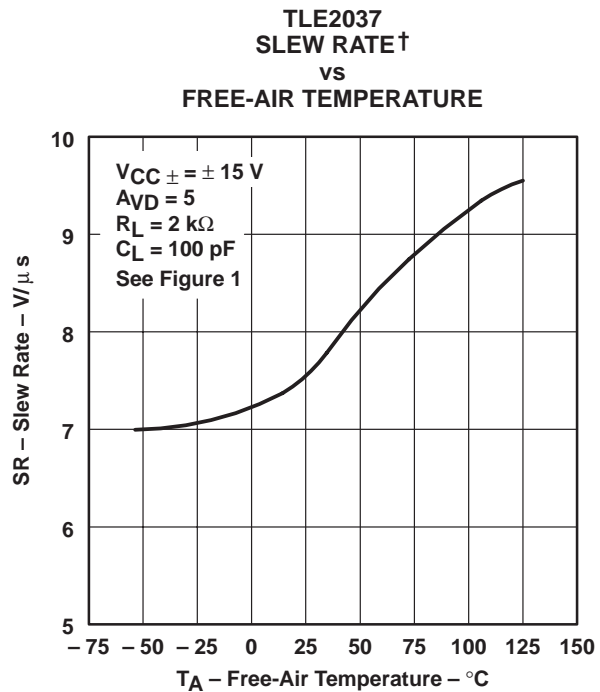


Figure 48

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2027
 PHASE MARGIN
 vs
 SUPPLY VOLTAGE

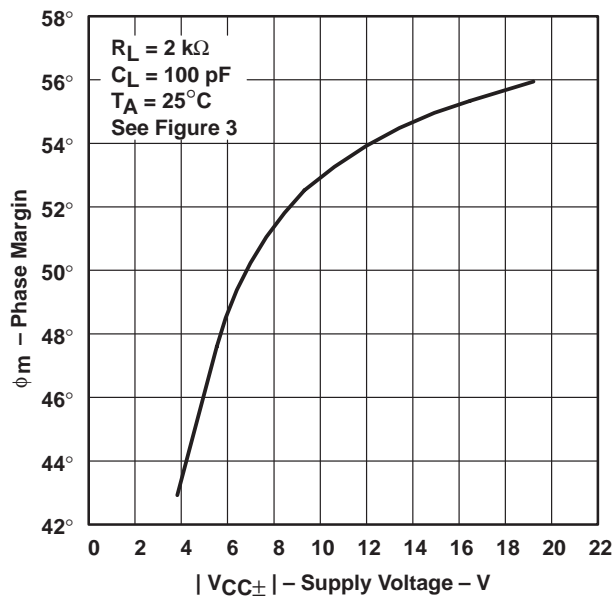


Figure 49

TLE2037
 PHASE MARGIN
 vs
 SUPPLY VOLTAGE

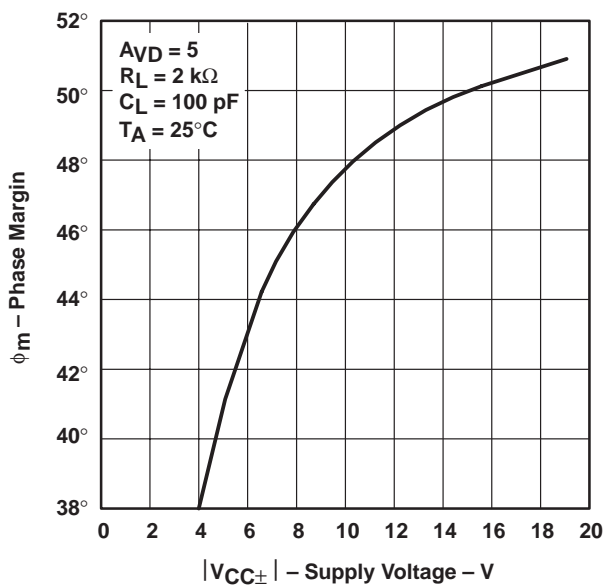


Figure 50

TLE2027
 PHASE MARGIN
 vs
 LOAD CAPACITANCE

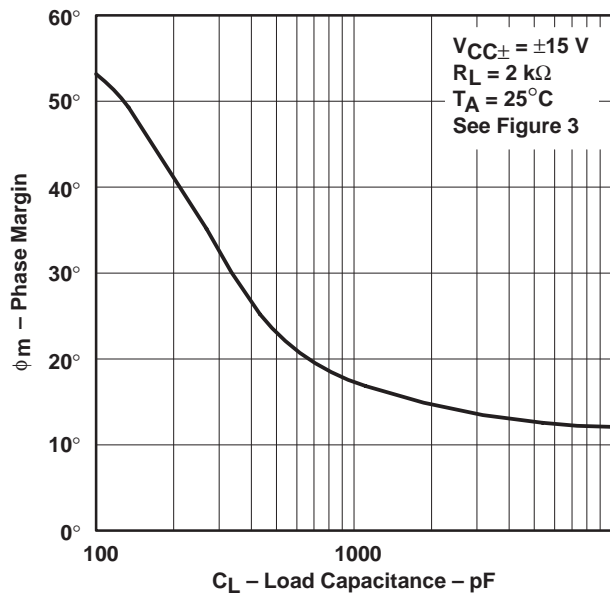


Figure 51

TLE2037
 PHASE MARGIN
 vs
 LOAD CAPACITANCE

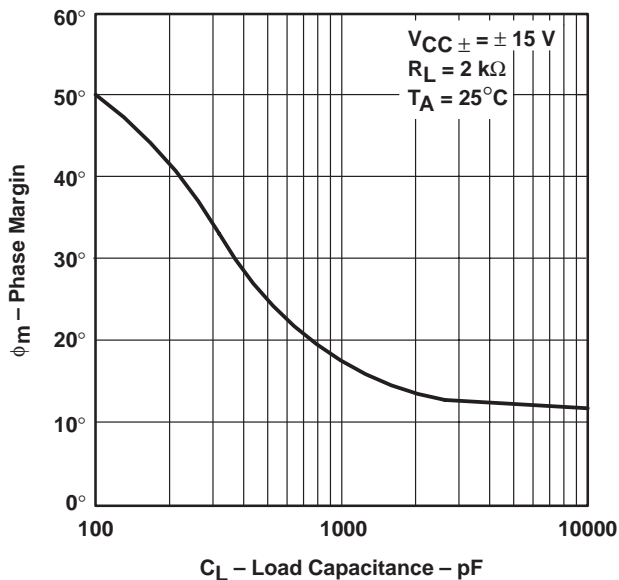


Figure 52

TYPICAL CHARACTERISTICS

TLE2027
 PHASE MARGIN†
 vs
 FREE-AIR TEMPERATURE

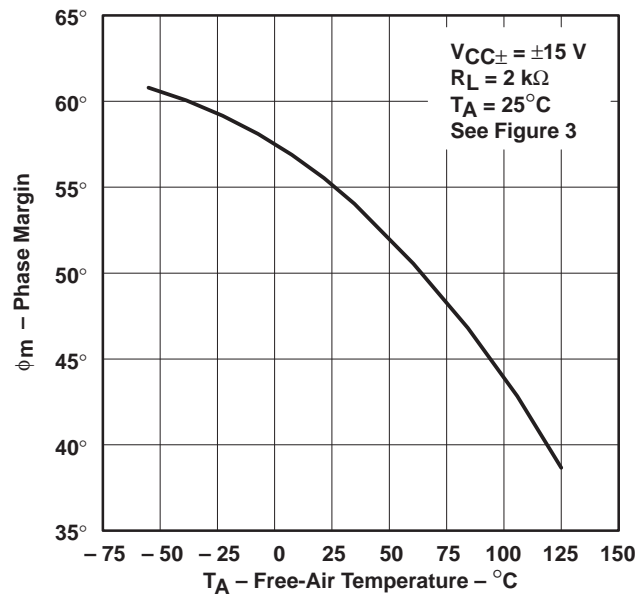


Figure 53

TLE2037
 PHASE MARGIN†
 vs
 FREE-AIR TEMPERATURE

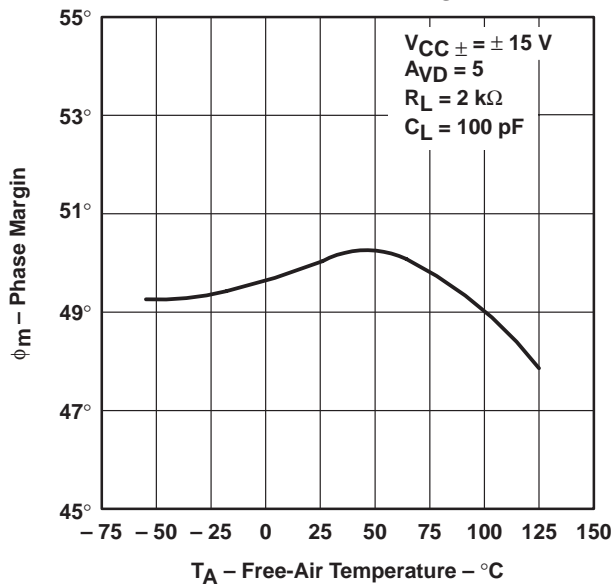


Figure 54

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

input offset voltage nulling

The TLE2027 and TLE2037 series offers external null pins that can be used to further reduce the input offset voltage. The circuits of Figure 55 can be connected as shown if the feature is desired. If external nulling is not needed, the null pins may be left disconnected.



Figure 55. Input Offset Voltage Nulling Circuits

voltage-follower applications

The TLE2027 circuitry includes input-protection diodes to limit the voltage across the input transistors; however, no provision is made in the circuit to limit the current if these diodes are forward biased. This condition can occur when the device is operated in the voltage-follower configuration and driven with a fast, large-signal pulse. It is recommended that a feedback resistor be used to limit the current to a maximum of 1 mA to prevent degradation of the device. Also, this feedback resistor forms a pole with the input capacitance of the device. For feedback resistor values greater than 10 kΩ, this pole degrades the amplifier phase margin. This problem can be alleviated by adding a capacitor (20 pF to 50 pF) in parallel with the feedback resistor (see Figure 56).

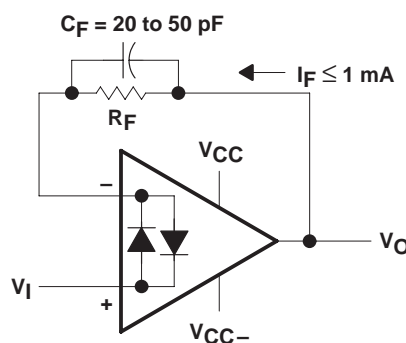


Figure 56. Voltage Follower

APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim *Parts*™, the model generation software used with Microsim *PSpice*™. The Boyle macromodel (see Note 6) and subcircuit in Figure 57, Figure 58, and Figure 59 were generated using the TLE20x7 typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Gain-bandwidth product
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 6: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", IEEE Journal of Solid-State Circuits, SC-9, 353 (1974).

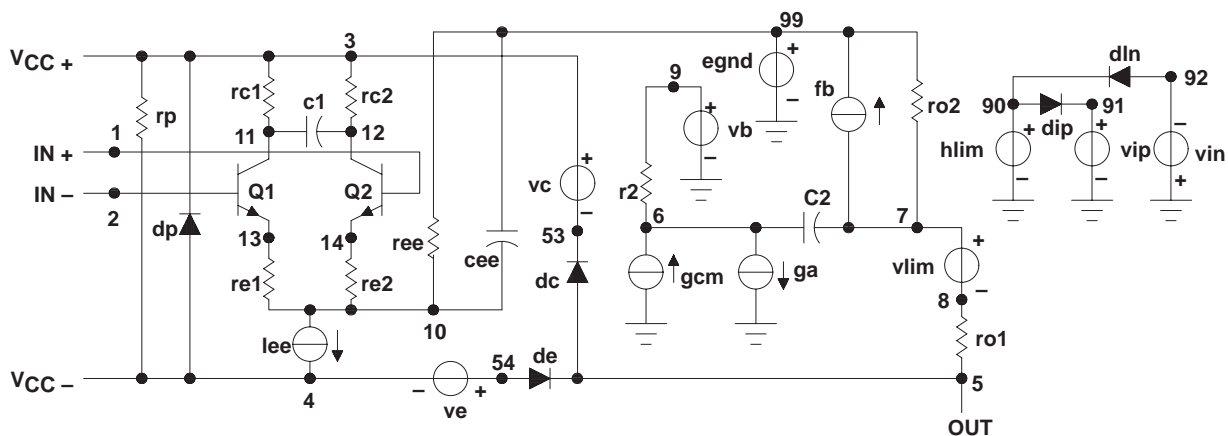


Figure 57. Boyle Macromodel

APPLICATION INFORMATION

macromodel information (continued)

```
.subckt TLE2027 1 2 3 4 5
*
c1      11  12  4.003E-12
c2      6   7   20.00E-12
dc      5   53  dz
de      54  5   dz
dlp     90  91  dz
dln     92  90  dx
dp      4   3   dz
egnd    99   0   poly(2) (3,0)
(4,0)  0  5  .5
fb      7   99  poly(5) vb vc
ve vlp vln 0 954.8E6 -1E9 1E9 1E9
-1E9
ga      6   0   11  12
2.062E-3
gcm     0   6   10  99
531.3E-12
iee     10  4   dc 56.01E-6
hlim    90  0   vlim 1K
ql      11  2   13  qx
q2      12  1   14  qx
r2      6   9   100.0E3
rc1     3   11  530.5
rc2     3   12  530.5
re1     13  10  -393.2
re2     14  10  -393.2
ree     10  99  3.571E6
ro1     8   5   25
ro2     7   99  25
rp      3   4   8.013E3
vb      9   0   dc 0
vc      3   53  dc 2.400
ve      54  4   dc 2.100
vlim    7   8   dc 0
vlp     91  0   dc 40
vln     0   92  dc 40
.modeldx D(Is=800.0E-18)
.modelqx NPN(Is=800.0E-18
Bf=7.000E3)
.ends
```

Figure 58. TLE2027 Macromodel Subcircuit

```
.subckt TLE2037 1 2 3 4 5
*
c1      11  12  4.003E-12
c2      6   7   7.500E-12
dc      5   53  dz
de      54  5   dz
dlp     90  91  dz
dln     92  90  dx
dp      4   3   dz
egnd    99   0   poly(2) (3,0)
(4,0)  0  .5  .5
fb      7   99  poly(5) vb vc
ve vip vln 0 923.4E6 A800E6
800E6 800E6 A800E6
ga      6   0   11  12  2.121E-3
gcm     0   6   10  99  597.7E-12
iee     10  4   dc 56.26E-6
hlim    90  0   vlim 1K
ql      11  2   13  qx
q2      12  1   14  qx
r2      6   9   100.0E3
rc1     3   11  471.5
rc2     3   12  471.5
re1     13  10  A448
re2     14  10  A448
ree     10  99  3.555E6
ro1     8   5   25
ro2     7   99  25
rp      3   4   8.013E3
vb      9   0   dc 0
vc      3   53  dc 2.400
ve      54  4   dc 2.100
vlim    7   8   dc 0
vlp     91  0   dc 40
vln     0   92  dc 40
.model  dxD(Is=800.0E-18)
.model  qxNPN(Is=800.0E-18
Bf=7.031E3)
.ends
```

Figure 59. TLE2037 Macromodel Subcircuit

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